

40A, 30V N-CHANNEL MOSFET ESD Protection

■ DESCRIPTION

The UTC UT7422Z is an N-channel MOSFET, it uses UTC's advanced technology to provide the customers with a minimum on state resistance, etc.

The UTC UT7422Z is suitable for load switch and battery protection applications.

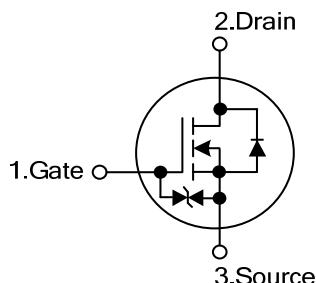
■ FEATURES

* $R_{DS(ON)} < 4.3m\Omega$ @ $V_{GS}=10V$, $I_D=20A$

$R_{DS(ON)} < 6.0m\Omega$ @ $V_{GS}=4.5V$, $I_D=16A$

* Low $R_{DS(ON)}$

■ SYMBOL



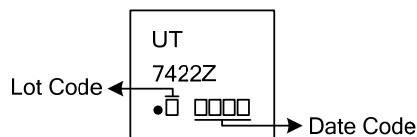
■ ORDERING INFORMATION

Ordering Number	Package	Pin Assignment								Packing
		1	2	3	4	5	6	7	8	
UT7422ZG-K08-3030-R	DFN-8(3x3)	S	S	S	G	D	D	D	D	Tape Reel

Note: Pin Assignment: G: Gate D: Drain S: Source

UT7422ZG-K08-3030-R	(1)Packing Type (2)Package Type (3)Green Package	(1) R: Tape Reel (2) K08-3030: DFN-8(3x3) (3) G: Halogen Free and Lead Free
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■ MARKING



■ ABSOLUTE MAXIMUM RATINGS ($T_A=25^\circ\text{C}$, unless otherwise noted)

PARAMETER	SYMBOL	RATINGS	UNIT
Drain-Source Voltage	V_{DSS}	30	V
Gate-Source Voltage	V_{GSS}	± 20	V
Continuous Drain Current $ T_C=25^\circ\text{C} $	I_D	40	A
Pulsed Drain Current (Note 2)	I_{DM}	200	A
Continuous Drain Current $ T_A=25^\circ\text{C} $	I_{DSM}	20	A
Avalanche Current (Note 2)	I_{AS}	45	A
Avalanche Energy $L=0.1\text{mH}$ (Note 2)	E_{AS}	101	mJ
Power Dissipation $ T_C=25^\circ\text{C} $	P_D	36	W
Junction Temperature	T_J	-55~+150	$^\circ\text{C}$
Storage Temperature Range	T_{STG}	-55~+150	$^\circ\text{C}$

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.
 Absolute maximum ratings are stress ratings only and functional device operation is not implied.
 2. Repetitive rating, pulse width limited by junction temperature $T_{J(MAX)}=150^\circ\text{C}$. Ratings are based on low frequency and duty cycles to keep initial $T_J=25^\circ\text{C}$.

■ THERMAL CHARACTERISTICS

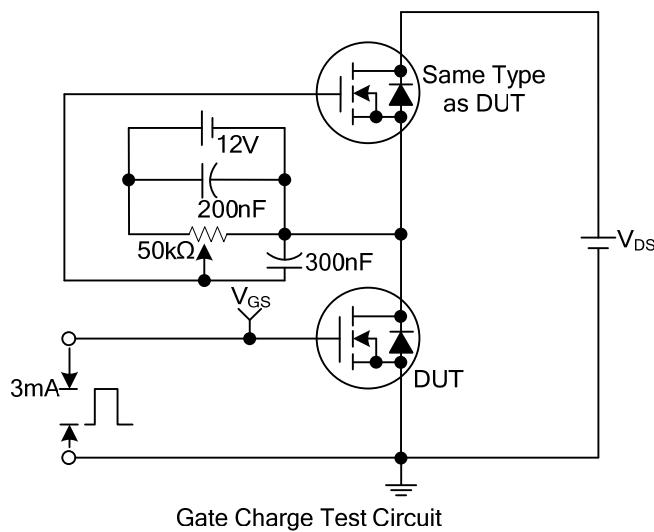
PARAMETER	SYMBOL	RATINGS	UNIT
Junction to Ambient	θ_{JA}	75	$^\circ\text{C/W}$
Junction-to-Case	θ_{JC}	3.4	$^\circ\text{C/W}$

■ ELECTRICAL CHARACTERISTICS ($T_J=25^\circ\text{C}$, unless otherwise noted)

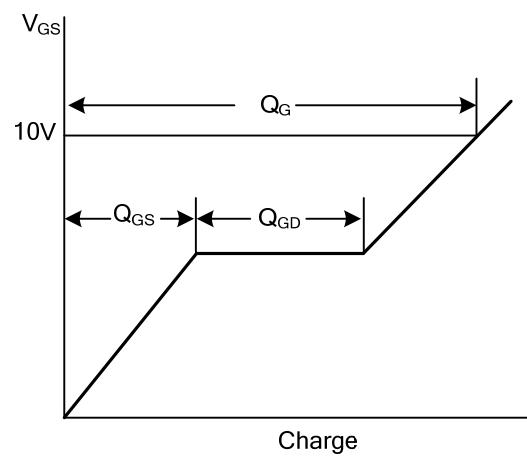
PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
STATIC PARAMETERS						
Drain-Source Breakdown Voltage	BV_{DSS}	$I_D=250\mu\text{A}, V_{GS}=0\text{V}$	30			V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=30\text{V}, V_{GS}=0\text{V}$		1		μA
		$V_{DS}=30\text{V}, V_{GS}=0\text{V}, T_J=55^\circ\text{C}$		5		μA
Gate-Source Leakage Current	I_{GSS}	$V_{GS}=\pm20\text{V}, V_{DS}=0\text{V}$		10		μA
ON CHARACTERISTICS						
Gate Threshold Voltage	$V_{GS(\text{TH})}$	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	1.3	1.85	2.4	V
On State Drain Current	$I_{D(\text{ON})}$	$V_{GS}=10\text{V}, V_{DS}=5\text{V}$	200			A
Static Drain-Source On-State Resistance	$R_{DS(\text{ON})}$	$V_{GS}=10\text{V}, I_D=20\text{A}$		3.5	4.3	$\text{m}\Omega$
		$V_{GS}=10\text{V}, I_D=20\text{A}, T_J=125^\circ\text{C}$		5.5	6.8	$\text{m}\Omega$
		$V_{GS}=4.5\text{V}, I_D=16\text{A}$		4.5	6	$\text{m}\Omega$
Forward Transconductance	g_{FS}	$V_{DS}=5\text{V}, I_D=20\text{A}$		85		S
DYNAMIC PARAMETERS						
Input Capacitance	C_{ISS}	$V_{GS}=0\text{V}, V_{DS}=15\text{V}, f=1.0\text{MHz}$	1950	2445	2940	pF
Output Capacitance	C_{OSS}		270	390	510	pF
Reverse Transfer Capacitance	C_{RSS}		130	220	310	pF
Gate Resistance	R_G	$V_{DS}=0\text{V}, V_{GS}=0\text{V}, f=1.0\text{MHz}$	1.2	2.4	3.6	Ω
SWITCHING PARAMETERS						
Total Gate Charge	Q_G	$V_{GS}=10\text{V}, V_{DS}=15\text{V}, I_D=20\text{A}$	32	41	50	nC
Total Gate Charge	Q_G	$V_{GS}=4.5\text{V}, V_{DS}=15\text{V}, I_D=20\text{A}$	15	19	24	nC
Gate to Source Charge	Q_{GS}			7.2		nC
Gate to Drain Charge	Q_{GD}			6.6		nC
Turn-ON Delay Time	$t_{D(\text{ON})}$	$V_{GS}=10\text{V}, V_{DS}=15\text{V}, R_L=0.75\Omega,$ $R_{\text{GEN}}=3\Omega$		7		ns
Rise Time	t_R			5		ns
Turn-OFF Delay Time	$t_{D(\text{OFF})}$			41.5		ns
Fall-Time	t_F			10.5		ns
SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS						
Diode Forward Voltage	V_{SD}	$I_S=1\text{A}, V_{GS}=0\text{V}$		0.7	1	V
Maximum Body-Diode Continuous Current (Note)	I_S				40	A
Body Diode Reverse Recovery Time	t_{rr}	$I_F=20\text{A}, dI/dt=500\text{A}/\mu\text{s}$		17.5	22	ns
Body Diode Reverse Recovery Charge	Q_{rr}			31	40	nC

Note: The maximum current rating is package limited.

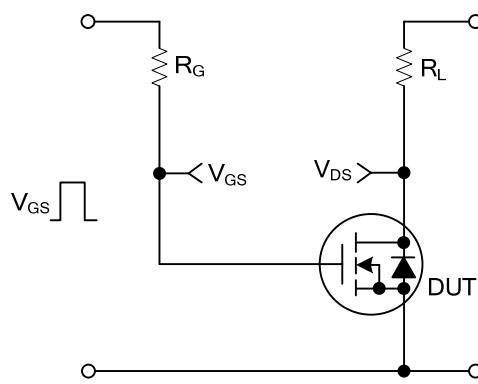
■ TEST CIRCUITS AND WAVEFORMS



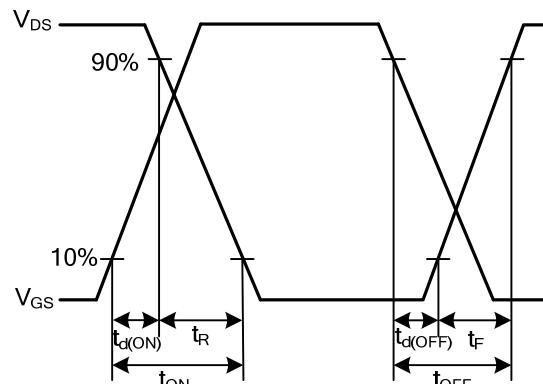
Gate Charge Test Circuit



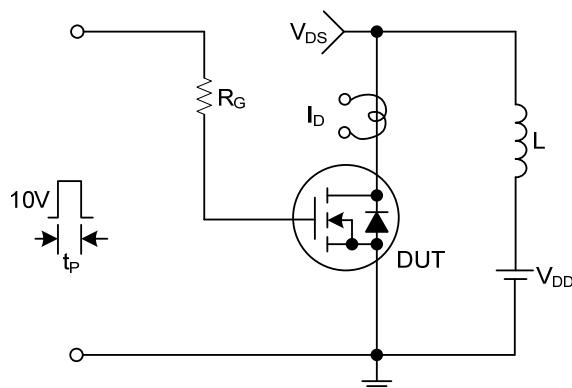
Gate Charge Waveforms



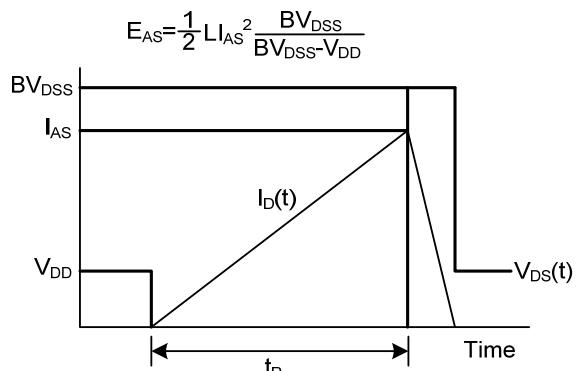
Resistive Switching Test Circuit



Resistive Switching Waveforms

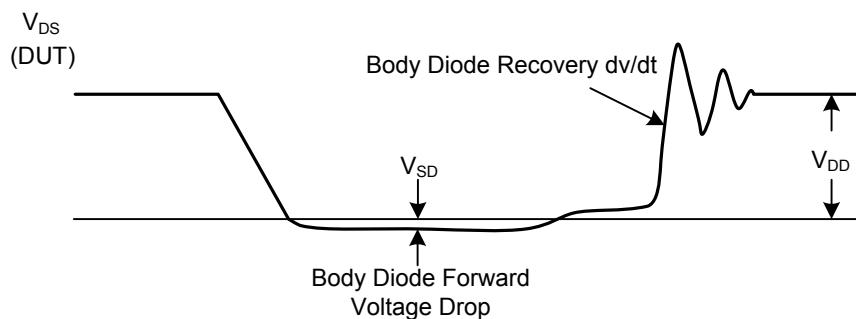
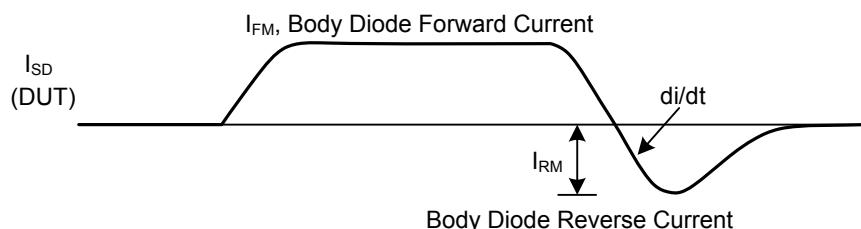
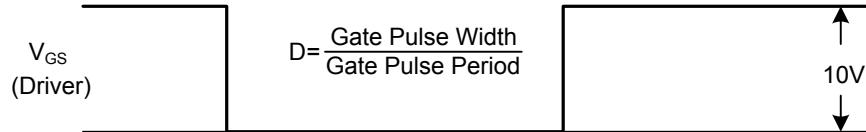
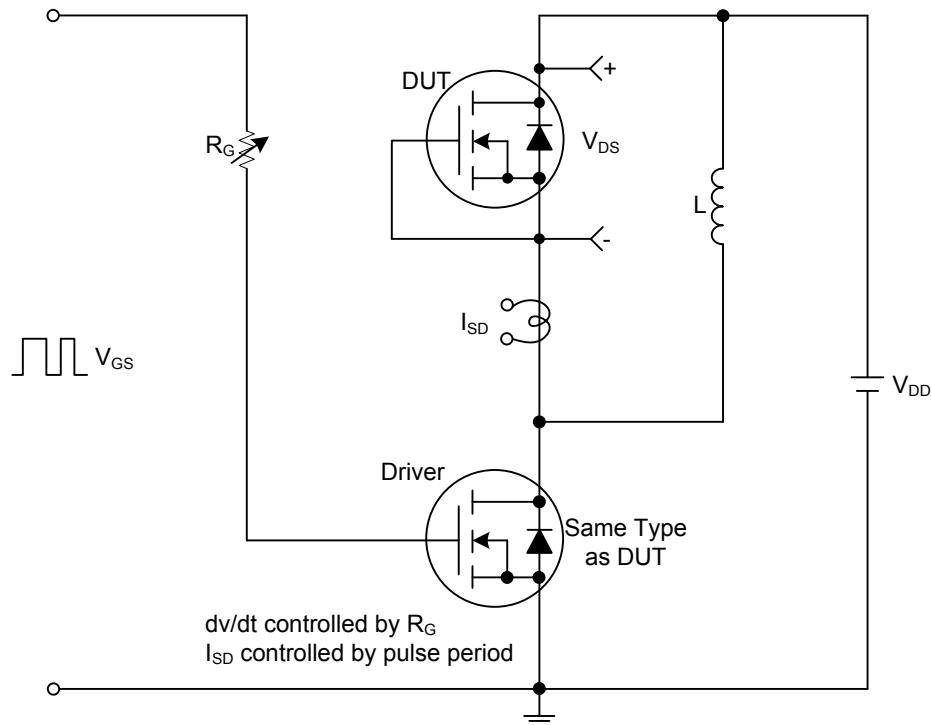


Unclamped Inductive Switching Test Circuit



Unclamped Inductive Switching Waveforms

■ TEST CIRCUITS AND WAVEFORMS (Cont.)



Peak Diode Recovery dv/dt Test Circuit and Waveforms

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